

Search Notes



Application No.

10/783,805

Examiner

Hien Tran

Applicant(s)

CHEN ET AL.

Art Unit

1764

SEARCHED

Class	Subclass	Date	Examiner
422	171, 177, 180	9/04	HT
181	227, 228		
60	297, 299, 311		
55	dig. 30, 524		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East Image Cl/Sub search. checked parent appln 08/997, 774	9/04	HT